1110-97825 PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Confirmation No.: To be assigned

Appl. No. : 10/586,445 Applicant : INAGAKI et al. Filed : 27 January 2005

Art Unit : To be assigned

: To be assigned Examiner

Docket No. : 1110-97825

Customer No.: 24628

Title: METHOD FOR PREDICTING PRECIPITATION BEHAVIOR OF OXYGEN IN SILICON SINGLE CRYSTAL, METHOD FOR DETERMINING PRODUCTION PARAMETER OF SILICON SINGLE CRYSTAL, AND STORAGE MEDIUM FOR STORING PROGRAM FOR PREDICTING PRECIPITATION BEHAVIOR OF OXYGEN IN SILICON SINGLE CRYSTAL

Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

CORRECTION

Dear Sir:

We submit the following corrected TRANSMITTAL LETTER TO THE UNITED STATES DESIGNATED/ELECTED OFFICE (DO/EO/US) CONCERNING A SUBMISSION UNDER 35 U.S.C. 371 to correct unintentional defects in the transmittal letter. No new material has been added through the submission of these corrections.

Application No. 10/586,445

Dated: 20 February 2009

Respectfully submitted,

Gerald T Shekleton

Reg. No. 27,466

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